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# Enhanced soft magnetic properties in N-doped amorphous FeCo thin film

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**Sputtered FeCoN<sub>x</sub> thin films with various nitrogen fraction are investigated in the quest of low lossy, soft magnetic thin films (SMFs) for high frequency inductor core. 100-nm thick FeCoN<sub>x</sub> films were deposited in N<sub>2</sub>+Ar environment (5 mTorr) with increasing N<sub>2</sub> volume percent,  $x\% = N_2/(Ar + N_2)$ , up to 30%. While FeCo thin film is isotropic, incorporation of nitrogen in the film exhibits a well-defined uniaxial magnetic anisotropy (UMA) as a result of reduced stress in the FeCoN<sub>x</sub> films. FeCoN<sub>17.5</sub> thin film with UMA shows superior all-round soft magnetic properties (saturation flux density ~ 1.7 T, coercivity ~ 7.8 Oe, real permeability ~ 381.7 and resistivity ~ 201 μΩ.cm). Study of the dynamic magnetic properties of FeCoN<sub>x</sub> (x= 15, 17.5 and 19%) films reveal two ferromagnetic resonance (FMR) peaks. Double resonance peaks in films with high concentration of nitrogen might be related to FeCo and Fe-N multiphase in the films. Furthermore, evolution of the real ( $\mu'$ ) and imaginary ( $\mu''$ ) part of the permeability spectra in the presence of dc magnetic bias field is also examined.**

**Index Terms**— Soft magnetic thin films, magnetic anisotropy, FeCo magnetic materials, permeability, saturation flux density.

## I. INTRODUCTION

**F**UTURE electronic devices demand efficient and miniaturized power delivery subsystems, such as dc-dc converters. The main obstacle towards miniaturization of the converters is the volume and weight of their passive components, i.e., transformers and/or inductors. Increasing the application switching frequency facilitates system integration towards Power System on Chip (PwrSoC) [1]. However, high switching frequencies entail enhanced core loss that eventually reduces the power conversion efficiency. Therefore, fabrication of integrated passive components of small size and high efficiency requires magnetic cores featuring high magnetic flux density to handle large current, low coercivity to stem hysteresis loss, and high electrical resistivity to reduce eddy-current losses. Significant progresses have been made in identifying suitable soft magnetic material integration technology, designs and material research [2]–[5].

Amorphous ferromagnetic alloys like CoZrTa, CoZrNb, NiFe boast with significantly higher saturation flux density  $B_s$  (~1.2-1.4 T) than ferrites (~0.5 T) but possess very low resistivity,  $\rho$  (~100 μΩ.cm) [6], [7]. Such a low resistivity entails significant eddy current losses in the magnetic materials at the frequency of interests (~100 MHz) for integrated voltage regulator (IVRs) applications [4]. On the other hand, owing to their high  $B_s$  (>2 T), Fe-based amorphous alloys like FeCoB, FeCo, FeC, etc. are gaining popularity in recent years [8], [9]. However, prohibitively large coercivity and low-resistivity in them remains an issue.

Among all these compositions, nitrides of FeCo thin films displayed the glimpses of all the right qualities (high  $B_s$ , low  $H_c$ , high anisotropy, and high value of  $\rho$ ) required for high-frequency applications [10]–[12]. Magnetic properties (static and dynamic) of FeCo-nitride films are hugely affected by

slight variation in the microstructure, opening lot of opportunities to alter their properties according to the requirement of the application. To mention a few, high efficiency transformers and inductors require a high value of the real part of permeability, whereas, electromagnetic wave attenuators require high imaginary permeability as well [13].

The magnetic flux density of Fe<sub>1-x</sub>Co<sub>x</sub> (0.3 < x < 0.5) is very high ~2.4 T [10], however, in-plane anisotropy and low coercivity is difficult to achieve in these films due to high magnetostriction constant ( $\lambda_s = 45-65 \times 10^{-6}$ ). Jung *et. al.* [14] reported a drastic decrease of  $H_c$  from 120 Oe to 1-3 Oe (along hard axis) in Fe<sub>0.65</sub>Co<sub>0.35</sub> films deposited on various under layers (Cu, NiFe, and Ru). Similarly, introducing nitrogen has also proven to be very effective to deposit high resistive film with soft magnetic properties [10], [15], [16]. However, high  $B_s$  and low  $H_c$  can be obtained only at an optimized value of nitrogen concentration, as at high concentration the magnetic properties are adversely affected. An extensive study on the effect of nitrogen concentration and substrate temperature by Kuo *et. al.* shows  $B_s$  of 2.39T for (Fe<sub>0.9</sub>Co<sub>0.1</sub>)<sub>0.92</sub>N<sub>0.08</sub> thin film deposited at substrate temperature near 200 °C, however,  $H_c$  was high (~80 Oe) [15]. Later, very low  $H_c$  of 0.6 Oe and  $B_s$  of 2.4 T are reported for a sandwiched structure of Ni<sub>0.81</sub>Fe<sub>0.19</sub>/(Fe<sub>0.7</sub>Co<sub>0.3</sub>)<sub>0.95</sub>N<sub>0.05</sub>/Ni<sub>0.81</sub>Fe<sub>0.19</sub> [10]. Although desired  $B_s$  and  $H_c$  are achieved in the sandwich structure, resistivity (~50 μΩ.cm) of the laminated film was poorer than CoZrTa due to incorporation of permalloy.

Here we report fabrication and physical properties of single layer soft magnetic films (SMFs), FeCoN<sub>x</sub>, with high saturation flux density, high resistivity, and pronounced magnetic anisotropy without any under layer. Having magnetic anisotropy is necessary to reduce core loss further by limiting the core switching to magnetic hard axis switching [17].

## II. EXPERIMENTAL

Nitrogen incorporated FeCo-SMFs with 100 nm thickness were deposited on Si (100) substrates, with 250 nm thermally grown SiO<sub>2</sub> top layer, using a dc magnetron sputtering system (Kurt J. Lesker Sputterer CMS-18). High purity (~99.99%) Fe<sub>65</sub>Co<sub>35</sub> targets were used for all the depositions. Base pressure of the chamber prior to all the depositions was maintained below  $1 \times 10^{-7}$  Torr, whereas, during depositions Ar + N<sub>2</sub> pressure was maintained at 5 mTorr. Films were grown at various N<sub>2</sub> concentrations by varying N<sub>2</sub> volume percent,  $x\% = N_2/(Ar + N_2)$ , between 0 and 30% in the chamber. Total 9 compositions of nitrogen incorporated FeCo films were prepared for  $x\% = 0, 5, 10, 12.5, 15, 17.5, 19, 20$  and 30 and the corresponding films are named as FeCo, FeCoN<sub>5</sub>, FeCoN<sub>10</sub> and so on, respectively.

KLA-Tencor P-17 Profiler was used to calibrate deposition rate and later to obtain stress and thickness of each film. To obtain the stress generated precisely due to the sputtered film, stress of the 4-inch wafer was measured before and after every film depositions, using the profiler for scan length of 80 mm. Pre and post-film stress profile and the magnetic film thickness were provided as input to calculate the film stress. Surface morphology and magnetic images were taken with an AFM (Bruker Dimension Icon). Structure of the films was examined by powder x-ray diffractometer (XRD, Philips X'pert diffractometer, Cu-K<sub>α</sub> radiation with  $\lambda=1.54 \text{ \AA}$ ). Room temperature resistivity was measured using a 4-point probe setup. The dc magnetic properties of 4-inch wafers were investigated by using a B-H loop tracer (SHB, MESA 200 HF). Magnetic field dependent magnetization was measured while the dc field was applied parallel to sample plane and the wafer was rotated in-plane to obtain both the easy and hard magnetic direction of the deposited film. Real and imaginary part of the permeability of all the films were measured using a high-frequency Permeameter (Ryowa, PMM 9G) at room temperature.

TABLE I: Properties of FeCo and FeCoN<sub>x</sub> films (at different N<sub>2</sub> volume percent, x).

Properties	FeCoN <sub>x</sub> (x in %)			
	$x = 0$	15	17.5	19
Stress (GPa)	1.1	0.85	0.89	0.74
Resistivity ( $\mu\Omega\cdot\text{cm}$ )	35	184	201	244
rms roughness (nm)	0.17	1.7	1.8	1.6
Saturation flux density, $B_s$ (T)	2.5	2.1	1.7	1.4
Coercivity, $H_c$ (Oe) (along hard axis)	100	16	7.8	9.3
Anisotropy field, $H_k$ (Oe)	-	62	63	65
Relative permeability, $\mu$ (at 100 MHz)	10	192.4	381.7	187.2

## III. RESULTS AND DISCUSSION

### A. Topology and structure

Atomic force microscopy (AFM) images show the surface morphology of FeCo and FeCoN<sub>17.5</sub> films as presented in Fig. 1(a). Nitrogen incorporation enhances grain size in the films and an indication of nanocluster formation is observed in FeCoN<sub>17.5</sub>. Root means square roughness measurement over  $10 \mu\text{m} \times 10 \mu\text{m}$  scan shows relatively smooth surfaces for both

FeCo and FeCoN<sub>17.5</sub> (0.17 nm and 1.80 nm, respectively). However, films grown in nitrogen environment show very different microscopic features (nanoclusters and higher rms roughness), which influences resistivity of the films.

Fig. 1(b-c) illustrates XRD pattern of FeCoN<sub>x</sub> films ( $x = 0, 15, 17.5$  and 19), deposited at different N<sub>2</sub> volume percent. XRD of sputtered FeCo film measured at ambient temperature shows (Fig. 1b) strong background signal at low  $2\theta$  values – indicative of an amorphous matrix. In addition, a nanocrystalline peak (Fig. 1b inset) that appears at  $2\theta=44.9^\circ$  can be indexed as BCC  $\alpha$ -FeCo (110) phase [18]. Other intense peaks are originated from the Si/SiO<sub>2</sub> substrate. Therefore, it can be summarized that the deposited film comprised of a tiny quantity of nanocrystalline  $\alpha$ -FeCo phase embedded in an amorphous matrix. As the films were deposited in Ar + N<sub>2</sub> atmosphere, nitrogen atoms occupied interstitial sites, causing mixture of  $\alpha'$ ,  $\alpha''$ ,  $\gamma'$ ,  $\epsilon$  and  $\zeta$  phases of FeN in these films [18], [19]. Inset of Fig 1(c) shows FeCoN<sub>x</sub> has very small peaks around  $2\theta=43.0^\circ - 46.3^\circ$ . It is very likely that  $\alpha''$ -Fe<sub>16</sub>N<sub>2</sub> and  $\gamma'$ -Fe<sub>4</sub>N phases appears in FeCoN<sub>15</sub> and FeCoN<sub>17.5</sub> films, whereas, FeCoN<sub>19</sub> has  $\epsilon$ -Fe<sub>3</sub>N phase. 4-point probe resistivity measurement (Fig. 1(d)) indicates that  $\rho$  is enhanced by nearly an order of magnitude in FeCoN<sub>19</sub> film (TABLE I), which is even higher than the Co–Zr–Ta–B systems [6]. A higher resistivity in soft magnetic thin film is desirable to reduce eddy current losses [7].  $\rho$  is maximum for FeCoN<sub>19</sub> film and it starts to decay with further enhancement in  $x$  (Fig. 1(d)).

Stress of the film remains tensile with a gradual decreased value for the films deposited at higher N<sub>2</sub> volume percent (Fig. 1(c)).

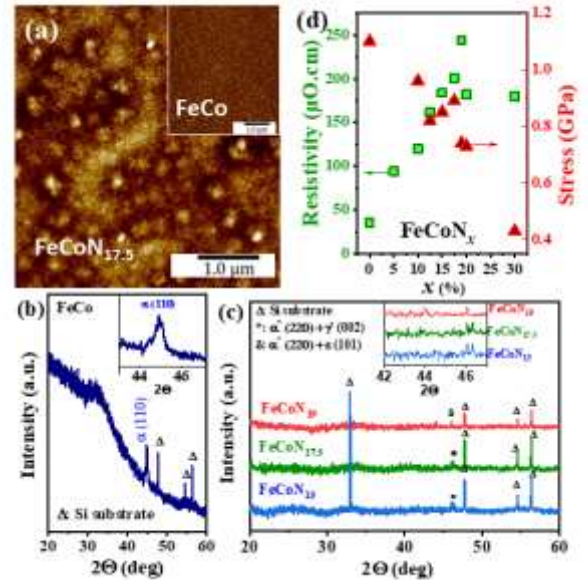


Fig. 1. (color online) (a) AFM images of FeCoN<sub>17.5</sub> films and the inset shows topology of FeCo film. (b) XRD diffraction pattern of FeCo amorphous film with a nanocrystalline  $\alpha$ -FeCo (110) phase and (c) XRD diffraction pattern of FeCoN<sub>x</sub> films containing FeCo amorphous phase and possible fractions of  $\alpha'$ -Fe<sub>16</sub>N<sub>2</sub> (220),  $\gamma'$ -Fe<sub>4</sub>N (002) and  $\epsilon$ -Fe<sub>3</sub>N (101) phases. (d) Variation in resistivity (left) and stress (right) of FeCoN<sub>x</sub> films fabricated at different N<sub>2</sub> volume percent.

### B. Static and dynamic magnetic studies

In-plane  $M$ - $H$  hysteresis loop of the  $\text{FeCoN}_x$  films (100 nm) deposited at different  $\text{N}_2$  volume percent,  $x$  are shown in Fig 2(a-d). The film deposited without nitrogen atmosphere is found to be isotropic in nature, whereas, introduction of nitrogen in the FeCo film has transformed it to in-plane anisotropic. All  $\text{FeCoN}_x$  films show different magnetic hysteresis along easy and hard anisotropy axis.  $H_c$  decreased dramatically by introducing nitrogen in FeCo during sputtering, i.e.  $\text{FeCoN}_x$  has much better soft magnetic properties compared to FeCo of the same thickness. Fig 2(c) demonstrates that  $\text{FeCoN}_{17.5}$  film exhibits in-plane uniaxial magnetic anisotropy (UMA) with moderate anisotropy field,  $H_k$  of 63 Oe and low  $H_c$  of 7.8 Oe along the magnetic hard axis direction. Magnetic parameters ( $B_s$ ,  $H_c$  and  $H_k$ ) of few SMFs are tabulated in TABLE I.

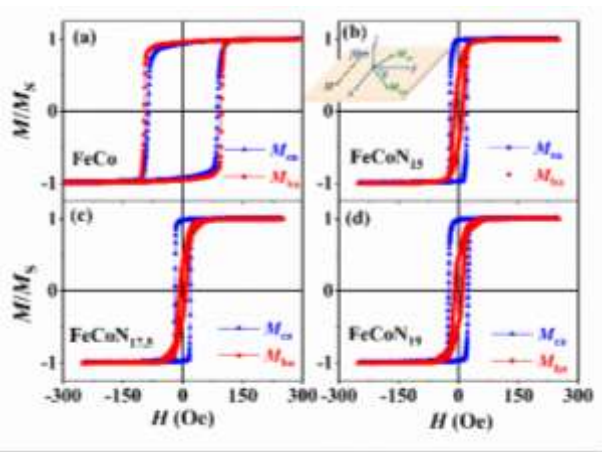


Fig. 2. (color online) Room temperature dc magnetization as a function of applied field ( $H$ ) for FeCo thin film (100 nm) deposited at different  $\text{N}_2$  volume percent.  $M_{ea}$  and  $M_{ha}$  correspond to the magnetization along easy and hard magnetic axis of the films, respectively.

Fig. 3 indicates modification of  $B_s$  and  $H_c$  with  $x$  in  $\text{FeCoN}_x$  films. As  $\text{N}_2$  volume percent increases from 0 to 12.5%,  $B_s$  shows a gradual decrease, but at  $\text{N}_2$  of 15%  $B_s$  suddenly jumps up to  $\sim 2.07$  T followed by a decay when  $B_s$  drops to 0.4 T for  $\text{N}_2$  of 20%. Similarly,  $H_c$  initially decreased, showed minima at  $\text{N}_2$  of 17.5% and then increases steeply with higher  $\text{N}_2$  volume percent. The lowest  $H_c$  of  $\sim 7.8$  Oe is achieved along hard axis in  $\text{FeCoN}_{17.5}$  which is better than the recently reported FeCo/Au system [9]. It is worth mentioning that as nitrogen was introduced to the films, tensile stress came down to 0.89 GPa in  $\text{FeCoN}_{17.5}$  from a value of 1.1 GPa in FeCo. Thus, introduction of nitrogen in FeCo system reduces the residual stress, in addition to the alteration in the microstructure and formation of an easy magnetization direction in the film [20]. In addition to these, literature indicates magnetic properties of iron nitride films strongly depend on  $\text{N}_2$  volume percent [19], [21]. Several nitride phases  $\alpha'$ ,  $\alpha''$ ,  $\gamma'$ ,  $\epsilon$  and  $\zeta$ , with different crystal structures and magnetic properties form in sequence as nitrogen fraction increases. Among these,  $\alpha''$ - $\text{Fe}_{16}\text{N}_2$  phase, forms at comparatively lower  $\text{N}_2$  volume percent, where the nitrogen atoms are ordered in the interstitial site, has the maximum

magnetic saturation and lowest coercivity. The formation of  $\gamma'$ - $\text{Fe}_4\text{N}$  and  $\epsilon$ - $\text{Fe}_3\text{N}$  phases, afterwards at higher  $\text{N}_2$  volume percent is known to lower the magnetization and raise the coercivity of the magnetic nitride films. This explains the poor soft magnetic properties in  $\text{FeCoN}_{19}$  film that deposited at a very high volume percent of  $\text{N}_2$ . Magnetic softness of these films could be further enhanced by controlling the grain size and optimizing film thicknesses [22]. Sun *et al.* has reported that proportionality relation between coercivity and grain size isn't valid for FeCo (with 30 at% Co) films, due to their non-negligible magnetoelastic anisotropy ( $K_\sigma = -95$  mJ/m<sup>3</sup>). For thick films (thickness  $> 100$  nm), coercivity is inversely proportional with the mean grain size [22].

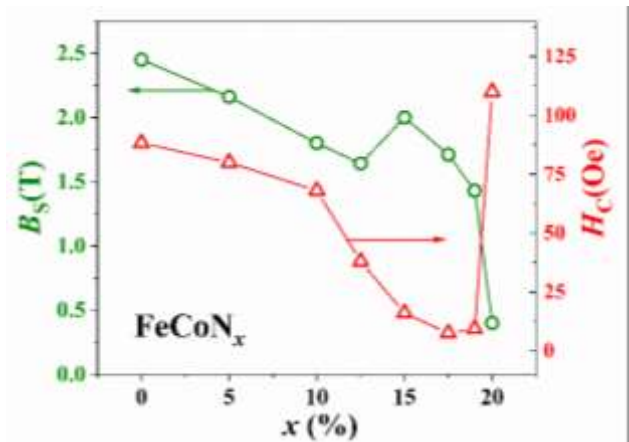


Fig. 3. (color online) The changes of saturation magnetization ( $B_s$ ) and coercivity ( $H_c$ ) with nitrogen volume percent for  $\text{FeCoN}_x$  films.

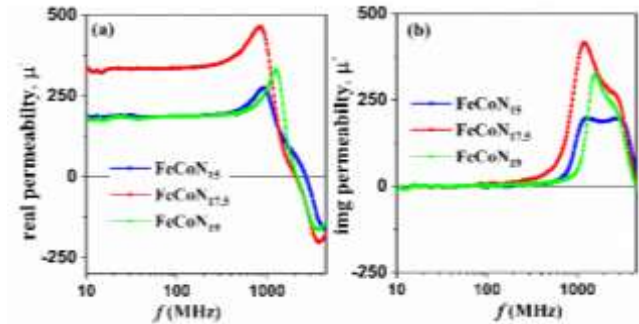


Fig. 4. (color online) High frequency (a) real permeability,  $\mu'$  and (b) imaginary permeability,  $\mu''$  spectra of  $\text{FeCoN}_x$  films ( $x = 15, 17.5$  and  $19$ ) under zero bias field.

In addition to low  $H_c$ ,  $\text{FeCoN}_x$  shows an improved ac magnetic response. Frequency dispersion of magnetic permeability,  $\mu = \mu' - i\mu''$ , of the films are measured at the frequency range 10-4500 MHz (Fig 4).  $\mu'$  is very sensitive to the nitrogen volume percent in the chamber while depositing the SMFs.  $\text{FeCoN}_{17.5}$  displays the highest relative permeability of 381.7 at 100 MHz. However, with further increasing the  $\text{N}_2$  volume percent to 19%,  $\mu'$  is reduced (TABLE I). Frequency dependent permeability spectra of the  $\text{FeCoN}_x$ -SMFs shows very distinct double resonance phenomenon and wide magnetic loss spectra with absorption peaks at frequency,  $f_{r1} \sim 1.2$  GHz and  $f_{r2} > 2.5$  GHz. However, absence of multidomain resonance peak below  $f_{r1}$  ensures magnetic homogeneity of the  $\text{FeCoN}_x$ -

SMFs [23]. These observations confirm that developing FeCo in nitrogen environment has positive effect on the magnetic properties and it can be further improved by tailoring the thickness of the film [20], [23]. The reason behind two resonance peaks in FeCoN<sub>x</sub> films, could be the existence of two magnetic phases, FeCo and some Fe-N phase(s). In [FeCo/FeCo-SiO<sub>2</sub>]<sub>n</sub> multilayer films, different dynamic anisotropies for FeCo and FeCo-SiO<sub>2</sub> layers contribute to two resonance peaks in the frequency dependent permeability spectra [24]. However, it is not straightforward to quantify the dispersion of the multiphase dynamic anisotropy fields [24], [25].

The complex permeability spectra of SMF FeCoN<sub>17.5</sub> with highest permeability value is measured under various external bias field ( $H_{bias}$ ) to investigate the characteristics of  $f_{r1}$  and  $f_{r2}$  peaks. As shown in Fig. 5, in the absence of a dc magnetic field,  $\mu'$  increases slowly with frequency and shows a peak at frequency  $\sim 0.85$  GHz. Application of dc bias field shifts  $\mu'$  and  $\mu''$  peaks toward higher frequency positions till the static magnetic saturation is reached (inset of Fig 5).  $f_{r1}$  and  $f_{r2}$  move to a higher frequency of  $\sim 2.5$  GHz and  $\sim 3.9$  GHz, respectively, at 100 Oe bias field (inset of Fig 5(b)). Both  $\mu'$  and  $\mu''$  are strongly suppressed at  $H_{bias}$  of 300 Oe.

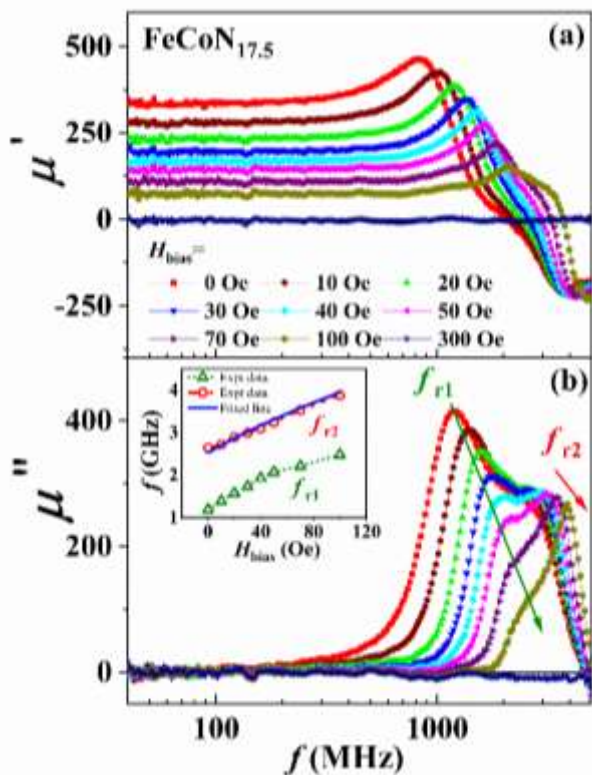


Fig. 5. (color online) (a) Real permeability,  $\mu'$  and (b) imaginary permeability,  $\mu''$  spectra of FeCoN<sub>17.5</sub> film at various external dc magnetic field ( $H_{bias}$ ). Inset of (b) shows shift of both resonance peaks ( $f_{r1}$  and  $f_{r2}$ ) with increasing  $H_{bias}$ . Symbols present the experimental data and the fitting of  $f_{r2}$ - $H_{bias}$  curve with the Kittel's equation is presented by solid line.

The shift of both resonance peaks ( $f_{r1}$  and  $f_{r2}$ ) towards higher frequencies with increasing  $H_{bias}$  confirms the ferromagnetic nature of the resonance peaks (Inset of Fig 5(b)) [26]. Monotonic increase of  $f_{r2}$  with  $H_{bias}$  indicates electron spin type

resonance resulting from the main amorphous FeCo phase. In contrast,  $f_{r1}$  exhibits a two-step increase of FMR – indicative of the presence of multiple magnetic phases of varied cluster sizes as evidenced in the XRD and AFM data (Fig 1).

Spin resonance frequency shifts towards higher frequency as the external bias field,  $H_{bias}$ , is applied. The Kittel condition for the in-plane ferromagnetic resonance (FMR) indicates how the resonance frequency,  $f_r$ , changes with the applied bias field, expressed as,  $f_r = \frac{\gamma}{2\pi} \sqrt{(H_k + H_{bias})(H_k + 4\pi M_S + H_{bias})}$ , [28] where  $4\pi M_S$  is the saturation magnetization, and  $\gamma$  the gyromagnetic ratio, is related to the Landé g-factor with the relation  $\gamma = (g\mu_B/\hbar)$ , where  $\hbar$  is the reduced Planck's constant and  $\mu_B$  is the Bohr magneton.  $f_{r2}$ - $H_{bias}$  curve was fitted with the Kittel's equation and  $\gamma$  of  $1.45 \times 10^7$  s<sup>-1</sup>.Oe<sup>-1</sup> and anisotropy field of 70 Oe was obtained for FeCoN<sub>17.5</sub> film.

### C. CONCLUSION

Nitrogen incorporated FeCoN<sub>x</sub> films with enhanced soft magnetic properties were developed by sputtering. These films are expected to have lower iron losses than FeCo-films as the hysteresis losses and eddy current losses are substantially lowered by reduced coercivity and increased resistivity respectively. Moreover, very low  $\tan\delta$  even at 100 MHz renders insignificant anomalous losses, making them potential core material for the inductors and transformers of next-gen on-chip power converters. Different nitrogen fraction in the films are obtained by altering the N<sub>2</sub> volume percent while keeping the deposition chamber pressure at 5 mTorr. Nearly seven times enhancement in electrical resistivity (244  $\mu\Omega\cdot\text{cm}$ ) was achieved in FeCoN<sub>19</sub> compared to FeCo film. The presence of nitrogen affects the high  $B_s$  of FeCo film to some extent, but it reduces the coercivity nearly ten-fold. FeCoN<sub>17.5</sub> film displays lowest  $H_c$  of 7.8 Oe with  $B_s$  of 1.7 T. Significantly softer magnetic behaviors in FeCoN<sub>x</sub> films compared to FeCo could be attributed to reduction in residual stress in presence of nitrogen atoms. Room temperature permeability results indicate ferromagnetic resonance above 1 GHz for all the films. The resonance loss characteristics of the FeCoN<sub>x</sub> films exhibits two peaks at  $\sim 1$  GHz and  $\sim 2.5$  GHz – indicative of the presence of multiple magnetic phases. At 100 MHz, FeCoN<sub>17.5</sub> has permeability of 381.7 – the highest among all samples. Ferromagnetic resonance frequency shifts towards higher frequencies with increasing  $x$ . High saturation flux density, permeability, resistivity and also ability to tune the FMR frequency over a wide range makes FeCoN<sub>x</sub> very useful for high-frequency inductor core application.

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